Notice of References Cited Application/Control No. 10/674,292 Examiner Yewebdar T. Tadesse Applicant(s)/Patent Under Reexamination HASEI ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,599,582	07-2003	Kiguchi et al.	427/466
*	В	US-2003/0232128 A1	12-2003	Furusawa et al.	427/58
	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-		·	
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.